

**Search Notes**

Application/Control No.

10/809,215

Examiner

Hung Vu

Applicant(s)/Patent under  
Reexamination

UCHIDA ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR